


<b>Search Notes</b> 	<b>Application/Control No.</b> 10501005	<b>Applicant(s)/Patent Under Reexamination</b> TAKENAKA ET AL.
	<b>Examiner</b> KARL I TAMAI	<b>Art Unit</b> 2834

SEARCHED			
Class	Subclass	Date	Examiner
310	64, 54, 52, 89	4/2/20084	kit
	update search	10/10/2008	kit

SEARCH NOTES		
Search Notes	Date	Examiner
h02k009/00, 02, 06, 19	4/24/2008	kit

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	see attached	12/31/2008	kit

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